

Search Notes



Application/Control No.

10/702,442

Examiner

Kin-Chan Chen

Applicant(s)/Patent under Reexamination

KIN ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
438	704	7/29/2005	KCC
438	745		
430	329		
134	1.3		
134	2		
134	3	7/29/05	KCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST key words search, USPAT, US-PGPUB, EPO, JPO, Derwent, IBM-TDB, inventor search.	7/27/2005	KCC